

Features

- Broad Bandwidth
- Specified from 50 MHz to 20 GHz
- Usable from 50 MHz to 26.5 GHz
- Lower Insertion Loss / Higher Isolation
- Fully Monolithic, Glass Encapsulated Chip
- Up to +33 dBm CW Power Handling @ +25°C
- RoHS* Compliant

Description

The MASW-001100-1190 (SPST), MASW-002100-1192 (SPDT) and MASW-003100-1192 (SP3T) are series-shunt, broadband, PIN diode switches made with MACOM's HMIC™ (Heterolithic Microwave Integrated Circuit) process. This process allows the silicon pedestals which form the series - shunt diodes and vias to be embedded into low loss, low dispersion glass. By also incorporating small spacing between circuit elements, the result is an HMIC chip with low insertion loss and high isolation at frequencies up to 26.5 GHz.

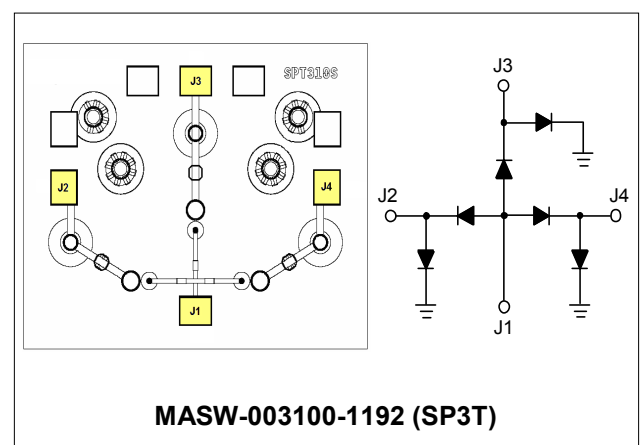
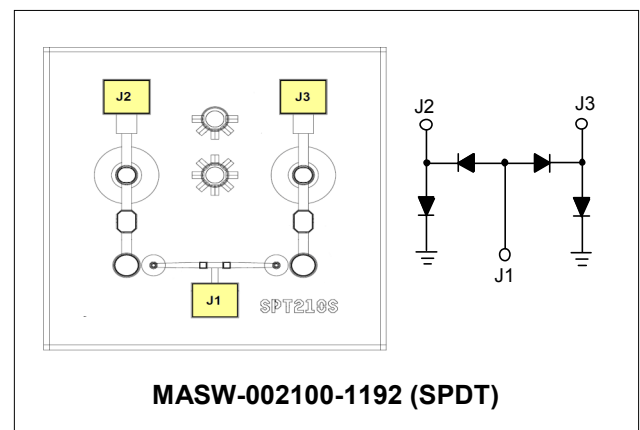
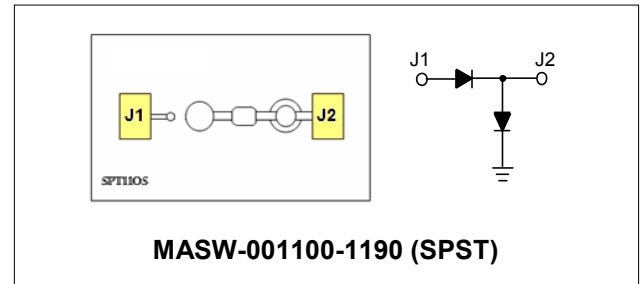
They are designed for use as moderate power, high performance switches and provide superior performance when compared to similar designs that use discrete components.

The top side of the chip is protected by a polymer coating for manual or automatic handling and large gold bond pads help facilitate connection of low inductance ribbons. The gold metallization on the backside of the chip allows for attachment via 80/20, gold/tin solder or conductive silver epoxy.

Ordering Information

Part Number	Package xx = 0G	Package xx = 0W
MASW-001100-1190(xx)	Gel Pack	Waffle Pack
MASW-002100-1192(xx)	Gel Pack	Waffle Pack
MASW-003100-1192(xx)	Gel Pack	Waffle Pack

Functional Diagrams



*Restrictions on Hazardous Substances, European Union Directive 2011/65/EU.

MASW-00x100 Series



HMIC™ Silicon PIN Diode Switches

Rev. V7

Electrical Specifications: $T_A = 25^\circ\text{C}$, 20 mA

MASW-001100-1190 (SPST)

Parameter	Test Conditions	Units	Min.	Typ.	Max.
Insertion Loss	6 GHz	dB	—	0.4	0.7
	13 GHz			0.5	0.9
	20 GHz			0.7	1.2
Isolation	6 GHz	dB	46	55	—
	13 GHz		39	47	
	20 GHz		34	42	
Input Return Loss	6 GHz	dB	22	31	—
	13 GHz		15	33	
	20 GHz		14	27	
Switching Speed ¹	—	ns	—	50	—
Voltage Rating ²	—	V	—	—	50
Signal Compression	500 mW, 1 GHz	dB	—	0.2	—

MASW-002100-1192 (SPDT)

Parameter	Test Conditions	Units	Min.	Typ.	Max.
Insertion Loss	6 GHz	dB	—	0.4	0.7
	13 GHz			0.5	1.0
	20 GHz			0.7	1.2
Isolation	6 GHz	dB	48	63	—
	13 GHz		40	50	
	20 GHz		34	42	
Input Return Loss	6 GHz	dB	20	27	—
	13 GHz		18	25	
	20 GHz		15	25	
Switching Speed ¹	—	ns	—	50	—
Voltage Rating ²	—	V	—	—	50
Signal Compression	500 mW, 1 GHz	dB	—	0.2	—

MASW-003100-1192 (SP3T)

Parameter	Test Conditions	Units	Min.	Typ.	Max.
Insertion Loss	6 GHz	dB	—	0.5	0.8
	13 GHz			0.7	1.1
	20 GHz			0.9	1.5
Isolation	6 GHz	dB	49	57	—
	13 GHz		42	48	
	20 GHz		33	42	
Input Return Loss	6 GHz	dB	20	24	—
	13 GHz		14	22	
	20 GHz		11	21	
Switching Speed ¹	—	ns	—	50	—
Voltage Rating ²	—	V	—	—	50
Signal Compression	500 mW, 1 GHz	dB	—	0.2	—

1. Typical switching speed is measured from (10% to 90% and 90% to 10% of detected RF voltage), driven by TTL compatible drivers. In the modulating state, (the switching port is modulating, all other ports are in steady state isolation.) The switching speed is measured using an RC network using the following values: $R = 50 - 200 \Omega$, $C = 390 - 1000 \text{ pF}$. Driver spike current, $I_C = C \text{ dv/dt}$, ratio of spike current to steady state current, is typically 10:1.
2. Maximum reverse leakage current in either the shunt or series PIN diodes shall be 10 μA maximum at -50 volts.

M/A-COM Technology Solutions Inc. (MACOM) and its affiliates reserve the right to make changes to the product(s) or information contained herein without notice.
Visit www.macom.com for additional data sheets and product information.

Absolute Maximum Ratings^{3,4,5}

Parameter	Absolute Maximum
RF CW Incident Power	+33 dBm
Reverse Voltage	-50 V
Bias Current per Port	±50 mA @ +25°C
Operating Temperature	-65°C to +125°C
Storage Temperature	-65°C to +150°C
Junction Temperature	+175°C

- Exceeding any one or combination of these limits may cause permanent damage to this device.
- MACOM does not recommend sustained operation near these survivability limits.
- Maximum operating conditions for a combination of RF power, DC bias and temperature: +33 dBm CW @ 15 mA (per diode) @ +85°C.

Handling Procedures

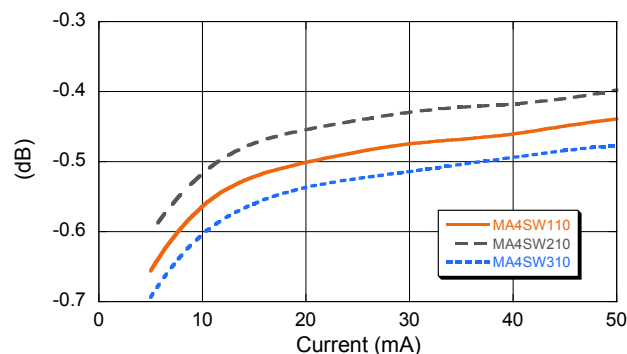
Please observe the following precautions to avoid damage:

Static Sensitivity

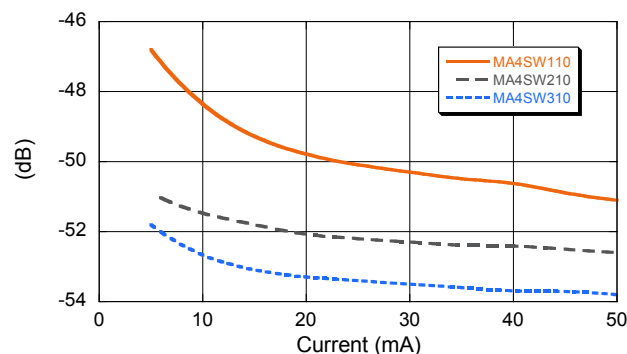
These electronic devices are sensitive to electrostatic discharge (ESD) and can be damaged by static electricity. Proper ESD control techniques should be used when handling these Class 0 (HBM) and Class C1 (CDM) devices.

Typical Performance Curves @ 10 GHz:

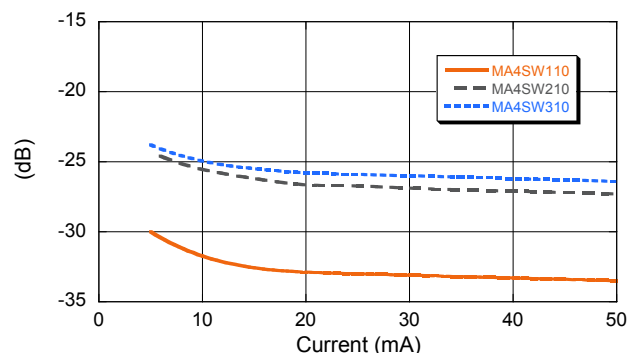
Insertion Loss vs. Bias Current



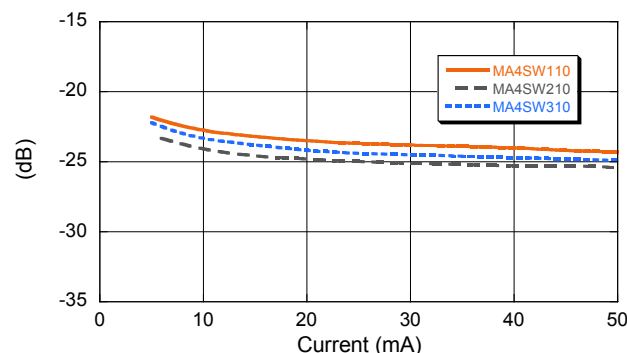
Isolation vs. Bias Current



Input Return Loss vs. Bias Current



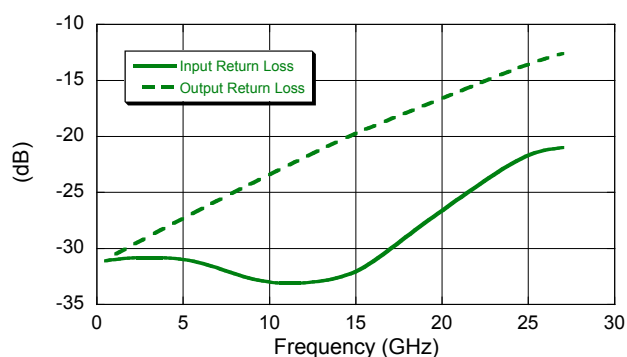
Output Return Loss vs. Bias Current



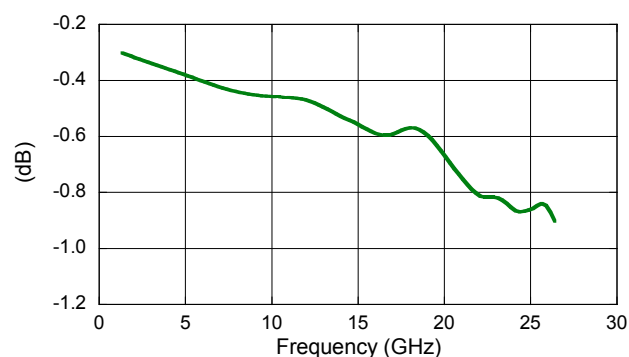
Typical Performance Curves @ $T_A = +25^\circ\text{C}$, 20 mA Bias Current

MASW-001100-1190

Return Loss vs. Frequency

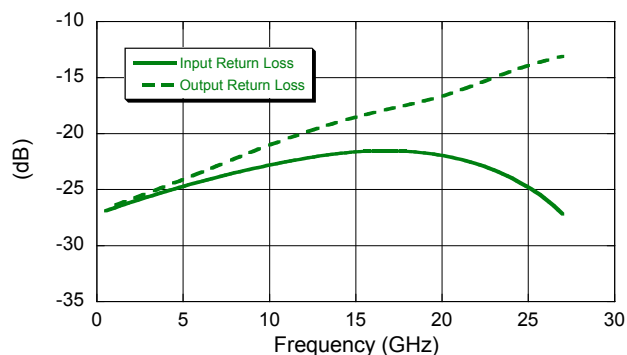


Insertion Loss vs. Frequency

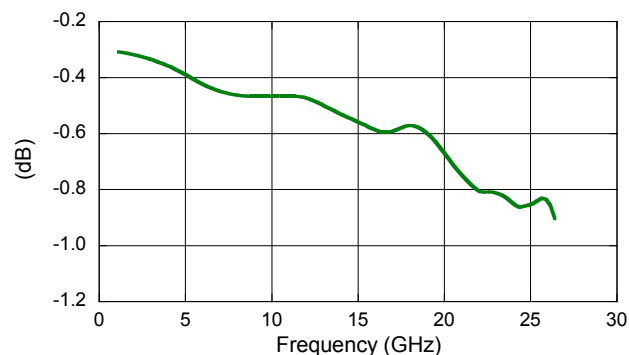


MASW-002100-1192

Return Loss vs. Frequency

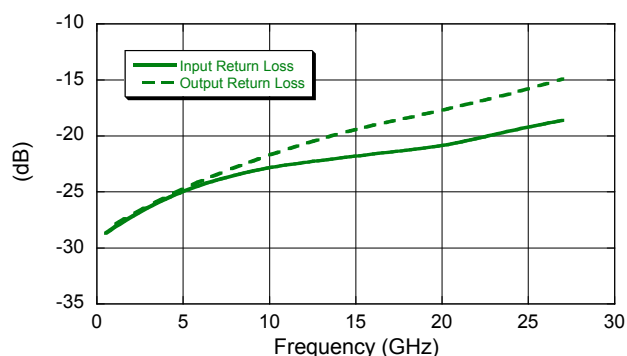


Insertion Loss vs. Frequency

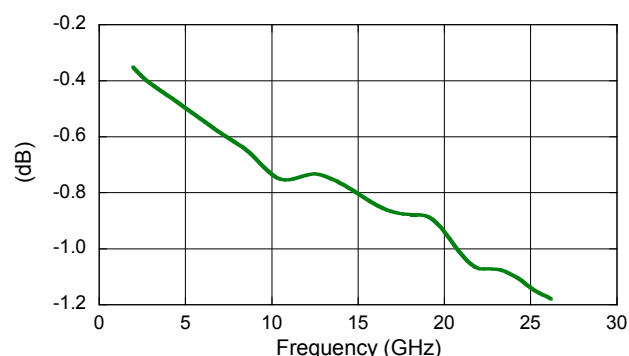


MASW-003100-1192

Return Loss vs. Frequency



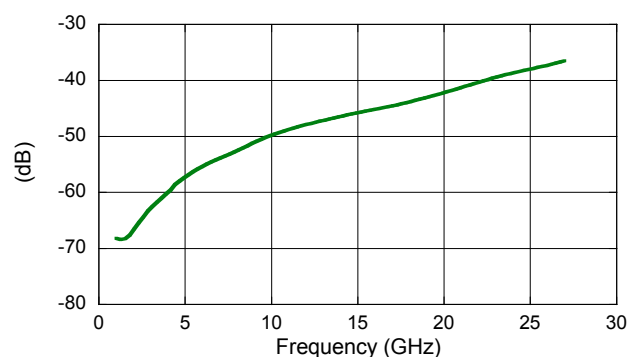
Insertion Loss vs. Frequency



Typical Performance Curves @ $T_A = +25^\circ\text{C}$, 20 mA Bias Current

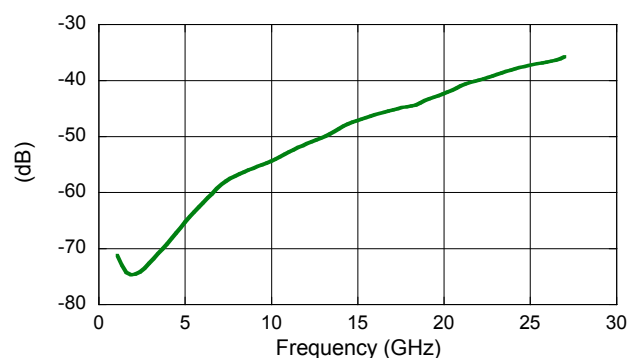
MASW-001100-1190

Isolation vs. Frequency



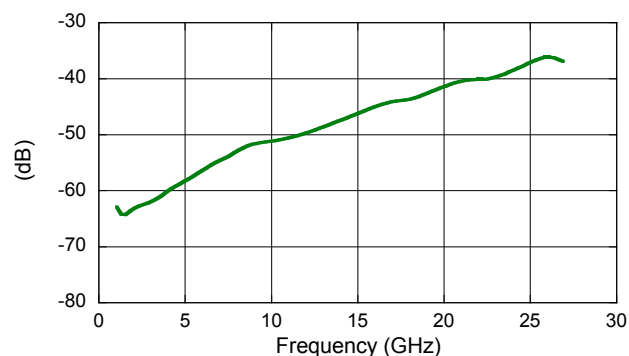
MASW-002100-1192

Isolation vs. Frequency



MASW-003100-1192

Isolation vs. Frequency



Operation of MASW-00x100 Series

The simultaneous application of a negative DC current to the low loss port and positive DC current to the isolated port is required for proper operation of the MA4SW series of PIN switches. The backside area of the die is the RF and DC ground return and the DC return is through the common Port J1. A constant current source should be used to supply the DC control currents. The control voltages at these points will not exceed ± 1.5 volts for supply currents up to ± 20 mA. In the low loss state, the series diode must be forward biased and the shunt diode reverse biased. On all isolated ports, the shunt diode is forward biased and the series diode is reverse biased.

Driver Connections and Drivers

MASW-001100-1190 (SPST)

DC Control Current (mA)	RF Output State
J2	J1-J2
-20	low loss
+20	Isolation
Compatible MACOM Driver MADR-007097-000100	

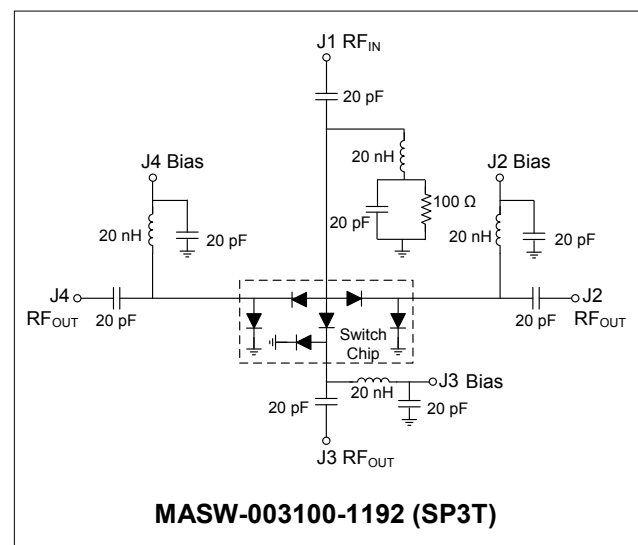
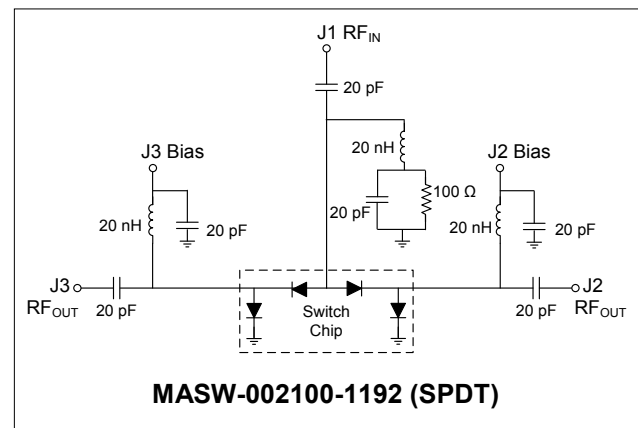
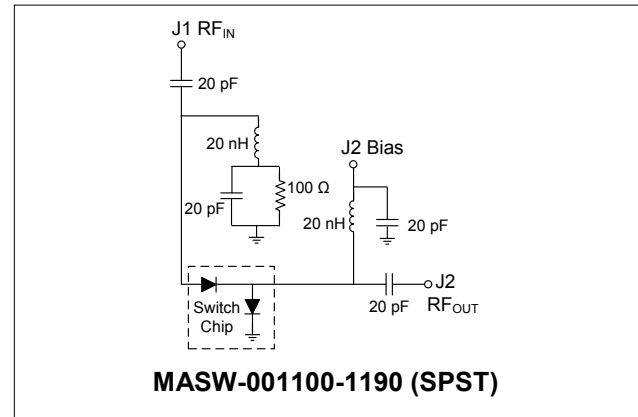
MASW-002100-1192 (SPDT)

DC Control Current (mA)		RF Output States	
J2	J3	J1-J2	J1-J3
-20	+20	low loss	Isolation
+20	-20	Isolation	low loss
Compatible MACOM Driver MADR-007097-000100			

MASW-003100-1192 (SP3T)

DC Control Current (mA)			RF Output States		
J2	J3	J4	J1-J2	J1-J3	J1-J4
-20	+20	+20	low loss	Isolation	Isolation
+20	-20	+20	Isolation	low loss	Isolation
+20	+20	-20	Isolation	Isolation	low loss
Compatible MACOM Driver MADR-009190-000100					

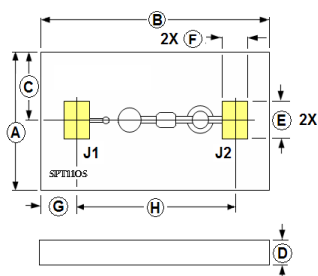
Bias Connections⁶



6. RLC values are for an operation frequency of 2-18 GHz and bias current of ± 20 mA per port..

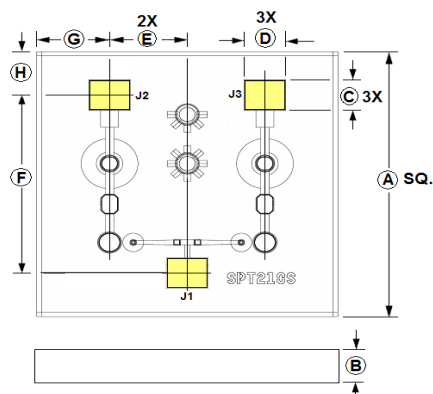
Chip Outline Drawings^{7,8}

MASW-001100-1190



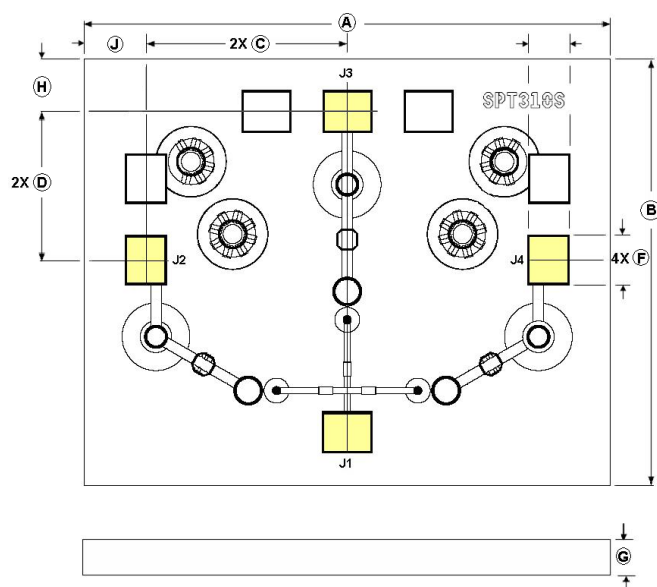
DIM	INCHES		MM	
	MIN.	MAX.	MIN.	MAX.
A	0.014	0.018	0.35	0.45
B	0.025	0.029	0.64	0.74
C	0.008 Ref.		0.20 Ref.	
D	0.004	0.006	0.10	0.15
E	0.004 Ref.		0.10 Ref.	
F	0.003 Ref.		0.08 Ref.	
G	0.003 Ref.		0.08 Ref.	
H	0.020 Ref.		0.52 Ref.	

MASW-002100-1192



DIM	INCHES		MM	
	MIN.	MAX.	MIN.	MAX.
A	0.029	0.033	0.73	0.83
B	0.004	0.006	0.10	0.15
C	0.004 Ref.		0.10 Ref.	
D	0.005 Ref.		0.13 Ref.	
E	0.009 Ref.		0.23 Ref.	
F	0.023 Ref.		0.58 Ref.	
G	0.007 Ref.		0.17 Ref.	
H	0.004 Ref.		0.10 Ref.	

MASW-003100-1192



DIM	INCHES		MM	
	MIN.	MAX.	MIN.	MAX.
A	0.046	0.050	1.16	1.26
B	0.036	0.040	0.92	1.02
C	0.019 Ref.		0.48 Ref.	
D	0.014 Ref.		0.36 Ref.	
E	0.004 Ref.		0.10 Ref.	
F	0.005 Ref.		0.13 Ref.	
G	0.004	0.006	0.10	0.15
H	0.005 Ref.		0.12 Ref.	
J	0.004 Ref.		0.10 Ref.	

7. Topside and backside metallization is gold, 2.5 μ m thick typical.
 8. Yellow areas indicate ribbon/wire bonding pads

Cleanliness

The chips should be handled in a clean environment free of dust and organic contamination.

Wire / Ribbon Bonding

Thermo compression wedge bonding using 0.003" x 0.00025" ribbon or 0.001" diameter gold wire is recommended. A work stage temperature of 150°C - 200°C, tool tip temperature of 120°C - 150°C and a downward force of 18 to 22 grams should be used. If ultrasonic energy is necessary, it should be adjusted to the minimum level required to achieve a good bond. Excessive power or force will fracture the silicon beneath the bond pad causing it to lift. RF bond wires and ribbons should be kept as short as possible for optimum RF performance.

Chip Mounting

HMIC switches have Ti-Pt-Au backside metallization and can be mounted using a gold-tin eutectic solder or conductive epoxy. Mounting surface must be free of contamination and flat.

Eutectic Die Attachment

80/20, gold-tin, solder is recommended. A re-flow oven or hot gas die bonder with a temperature setting of 290°C is normally used to melt the solder. The chip should not be exposed to temperatures greater than 320°C for more than 20 seconds. Typically no more than three seconds at peak temperature is required for attachment. RoHS compliant solders may also be used but solders rich in tin should be avoided as they will scavenge the backside gold and/or cause gold embrittlement.

Epoxy Die Attachment

A minimum amount of epoxy, 1 - 2 mils thick, should be used to attach chip. A thin epoxy fillet should be visible around the outer perimeter of the chip after placement. Epoxy cure time is typically 1 hour at 150°C.